

Testing Summary Getac K120 Tablet Docking Station

(7160-1084)

Summary of Tests Performed at Gamber-Johnson

Test Description	Test Parameters
Vibration –	Getac Developmental Testing Specification per Figure 1.
Operational	Test duration is two hours along three mutually orthogonal axes –
Test date: August, 2018	not simultaneously (6 hours total).
	Unit is unlocked
	OEM provided operating conditions
Vibration –	MIL-STD-810G, Method 514.6, Procedure 1, Category 4, per Figure
Operational	514.6C-1. Test duration is two hours along three mutually
RF Connection	orthogonal axes – not simultaneously (6 hours total).
Test date: August, 2018	Unit is unlocked
	OEM provided operating conditions
	 Test is performed simultaneously with operational test.
	 Test is monitored to record any breaks in RF connectivity
	during vibration.
Vibration –	Getac Developmental Testing Specification. MIL-STD-810G, Method
Non-Operational	514.6, Category 24, per Figure 514.6E-1. Test duration is one hour
(Minimum Integrity)	along three mutually orthogonal axes – not simultaneously (3 hours
Test date: August, 2018	total).
	Unit is unlocked
	OEM provided operating conditions
Shock – Bump Test	Getac Developmental Testing Specification. IEC 60068-2-27:2008.
Test date: August, 2018	1000 positive and negative pulses in the vertical axis, 2000 total.
	• 25G, 6ms half sine
	Unit is unlocked
Functional Shock -	Getac Developmental Testing Specification. MIL-STD-810G, Method
Operational	516.6, Procedure 1, 3 positive and 3 negative pulses each axis
Test date: August, 2018	(vertical, longitudinal and transverse), 18 pulses total.
	20G, 11ms Terminal Peak Saw-Tooth
	Unit is unlocked
Mechanical Shock	Getac Developmental Testing Specification. MIL-STD-810G, Method
Safety -	516.6, Procedure 1, 3 positive and 3 negative pulses each axis
Non-Operational	(vertical, longitudinal and transverse), 18 pulses total.
Test date: August, 2018	40G, 11ms half sine
	Unit is unlocked

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Directional Force	Getac Developmental Testing Specification.
Test	Connector Lateral-Force Life Test
Test date: October, 2018	 RJ-11, RJ-45, DC-in, HDMI, VGA, Ethernet
	■ 5Kg
	■ (10) 15 –Second cycles
	DC Jack Strength Test
	 Drop 1kg weight on DC jack
	 Cotton thread must exceed 15 cm
	 10 Cycles. One cycle equals 3 drops per direction.
Security Testing	Gamber-Johnson LLC Product Validation Testing Specification section
	3.8. An attempt to remove computer from docking station will be
	tested. Using one simple tool the computer should not be removed
	from docking station under in 60 seconds. No damage to the
	computer should occur.
	Unit is locked
Cycle Testing –	30,000 cycles of the docking connector, latching and locking
Non-Operational	mechanisms
Test date: August, 2018	
Electrostatic	ISO 10605, Section 8, Table C.2, Category 2 – Direct Air Discharge
Discharge –	
Operational	
Test date: Sept. 2018	

Summary of Tests Performed at Independent Facility

Summary of Tests Performed at Independent Facility		
Test Description	Test Parameters	
Humidity	MIL-STD 810G, Method 507.5, Procedure II, Aggravated, Table 507.5-	
Test date: Sept. 2018	IX	
	 Ten 24-hour cycles, temperature varied from 30°C to 60°C to 	
	30°C at constant 95% relative humidity.	
Thermal Shock	MIL-STD 810G, Method 503.5, Procedure I-C	
Test date: Sept. 2018	 Three cycles from 85°C to -40°C to 85°C 	
Low Temperature:	MIL-STD 810G, Method 502.5, Procedure II	
Operational	 -10°C Operating, 2-hour duration 	
Test date: Sept. 2018		
Low Temperature:	MIL-STD 810G, Method 502.5, Procedure I	
Storage	 -51°C Non-Operating, 4-hour duration 	
Test date: Sept. 2018		
High Temperature:	MIL-STD 810G, Method 501.5, Procedure II, Table 501.5-II, Induced	
Operational	Conditions	
Test date: Sept. 2018		

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	 Three 24-hour cycles, temperature varied from 30°C to 60°C
	to 30°C
High Temperature:	MIL-STD 810G, Method 502.5, Procedure I, Table 502.5-III, Induced
Storage	Conditions
Test date: Sept. 2018	 Seven 24-hour cycles, temperature varied from 33°C to 71°C
	to 33°C
Shock – Crash Hazard	SAE J1455, Section 4.11.3.5, per Figure 13
Test date: Sept. 2018	Unit is unlocked
EMC Testing	EN 50498:2010
Test date: August 2018	
EMC Testing	EN 55032:2015
Test date: August 2018	CISPR 32 – Class B
	 FCC Part 15, Subpart B – Class B
E-Mark	ECE R10 REV.5
Test date: Dec. 2018	

Other Certifications

Description	
EN 50581:2012 RoHS2 Directive 2011/65/EU	